nexperia

Quarterly Reliability Monitoring Results

Quarters: Q1/2022 to Q4/2023 Based on structural similarity

Supplier		User Part Number				
Nexperia B.V. Name of Laboratory Assembly reliability labs Based on AEC-Q101 Test		HPZR-C8V2-Q Part Description				
		SMD package				
		Test Conditions	Duration	# Lots	# Quantity	# Rejects
			TEST			
	Pre- and Post-Stress					
# E1	Electrical Test	Tamb = 25 °C	N/A	see below	all parts	see below
		JESD22-A113				
		Bake Tamb = 125 °C	24 hours			
	PC	Soak Tamb = 85 °C, RH = 85%	168 hours		64400	
# A1	Preconditioning	Reflow soldering	3 cycles	1514	64430	0
	11700	MIL-STD-750-1				
	HTRB High Temperature Reverse	M1038 Method A Tj = Tjmax, VR = 80 % of rated reverse				
# B1	Bias	voltage	1000 hours	250	11400	0
" 01	5.00	MIL-STD-750-1	1000 110015	230	11100	0
		M1038 Method B				
	SSOP	Tj = Tjmax, Iz = 100% of max. datasheet				
# B1b	Steady State Operational	reverse current	1000 hours	44	1920	0
	тс	JESD22-A104				
# A4	Temperature Cycling	-65 °C to Tjmax, not to exceed 150°C	1000 cycles	311	14080	0
# A3 or	UHAST Unbiased HAST	JESD22-A118				
# A3 or	UIDIASED HAST	Tamb = 130 °C, RH = 85 %	96 hours	311	14080	0
	AC	JESD22-A102 Tamb = 121 °C, RH = 100 %				
# A3 alt	Autoclave	Pressure = $205 \text{ kPa} (29.7 \text{ psia})$				
# AJ alt	Addedave					
	H3TRB	JESD22-A101				
	High Humidity High	Tamb = 85 °C, RH = 85%, VR = 80 % of				
# A2 alt	Temperature Reverse Bias	rated reverse voltage ^[1]	1000 hours	311	14080	0
	· · · · · · · · · · · · · · · · · · ·	MIL-STD-750 Method 1037				
	IOL	ton = toff, devices powered to insure ΔTj =				
# A5	Intermittent Operating Life	100 °C for 15000 cycles	1000 hours	312	14120	0
	RSH	JESD22-A111				
# C8	Resistance to Solder Heat	260 °C ± 5 °C	10 s	269	8070	0
	SD	1 675 662				
# C10	Solderability	J-STD-002		19	6660	0

[1] The maximum applied voltage is limited by test chamber set up and does not exceed 115V.

Calculation of FIT and MTTF

Test considered for FIT calculation: High Temperature Reverse Bias (HTRB, Test #B1) Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

2,68E+09
_

© 2024 Nexperia B.V.

All information hereunder is per Nexperia's best knowledge. This document does not provide for any representation or warranty express or implied by Nexperia. In case Nexperia has tested the product, this documentation reflects the outcome of the analysis of the actually tested parts only.

nexperia.com